

Search Notes

Application/Control No.

10/725,133

Examiner

W. Patty Chen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed previously cited references	5/11/2007	WPC
349/141 combined with key words search of all databases in EAST	5/11/2007	WPC